

Ultrafast modifcation of oxide glass surface hardness

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Abstract

Application of femtosecond lasers is widely utilized in micromachining transparent materials. We have successfully altered the surface hardness of various commercial silicate glasses using a high-intensity femtosecond pulse laser. The femtosecond laser generates pulse energy of 500 nJ with a central wavelength of 800 nm. Using a peak power of 2.2 W and a repetition rate of 5.1 MHz, we observed an 18–20% increase surface hardness in glasses with low-modifer content and 16.6% decrease in glasses with high-modifer content. All laser exposed glasses show no detectable induced-crystallization or surface ablation. X-ray photoelectron spectroscopy results of our samples confrmed that the laser irradiation had no detectable efect on surface chemistry. X-ray refectometry data showed the change in hardness was attributed to a thin layer with modifed density. Experimental results suggest the strengthening mechanism derives from local structural transformation of interatomic bond distances and angles.

1 Introduction

The interaction between femtosecond laser pulses and transparent materials has become an actively researched topic over the past two decades $[1-3]$ $[1-3]$. Recently, many interesting phenomena induced by femtosecond laser irradiation in transparent materials have been reported, i.e., nonreciprocity writing, oxidation and reduction of dopants, migration of ions and micro-fabrication of 3D structures [[3–](#page-7-1)[6\]](#page-7-2). Femtosecond laser pulses have the unique capability of irradiating a localized area with a large amount of energy. Deposition of energy in the glass network enables the structure to relax into a quasi-equilibrated state [[7\]](#page-7-3). Controlling and optimizing the glass structure with laser pulses involve nonlinear absorption efects. Linear absorption is not observed in pure transparent materials because of insufficient photon energy needed to overcome the large bandgap; however, when suffcient energy is applied to a glass, signifcant nonlinear absorption takes place [[1\]](#page-7-0).

Classifcation of refractive index modifcation has been ascribed as type I and II. Regions with highly localized

 \boxtimes Sean Locker stl4@alfred.edu increases in refractive index relative to the unexposed bulk are known as type I. These changes are typically observed in laser exposures of low fuence and often result from local heating or melting followed by immediate cooling and the formation of color centers due to breaking Si–O bonds [[8,](#page-7-4) [9](#page-7-5)]. Restructuring the glass matrix through a thermal process causes bond softening and subsequent ionic rearrangement; however, the degree of modulation is highly dependent on the thermal history and initial glass relaxation [[10\]](#page-7-6). Type II refractive index changes are induced by high temperature and pressure gradients, resulting in the formation of stress felds [[11\]](#page-7-7).

Random network and space groups in glass provide an opportunity to distort bonds and interbonding angles. Applying intense femtosecond laser pulses to glass will produce a highly nonlinear interaction often resulting in permanent changes in material structure. Given the size of the incident beam, effective nonlinear interaction and subsequent modifcations occur locally. Refractive index modifcations via femtosecond laser irradiation have been observed with pulse energies ranging from 0.1 to 10 µJ and repetition rates from 1 to 100 kHz [\[12](#page-7-8), [13\]](#page-7-9). These localized changes are highly dependent on composition and the positive or negative index changes tend to vary based on laser parameters. Processes using repetition rates greater than 200 kHz tend to observe minimal defect-induced damage [[14\]](#page-7-10). The present paper provides methods to increase surface hardness by applying high repetition rate ultrafast laser pulses.

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Surface swelling is a common side effect observed during waveguide writing; laser-induced stresses manifest from confned quenching after near-surface exposure. Multiphoton absorption and subsequent plasma formation generate the necessary temperature and pressure to result in structural changes [\[15](#page-7-11)[–17\]](#page-7-12). Localized energy deposited beneath the material surface mitigates material oblation, therefore, allowing stresses to develop as the irradiated region expands. As Bhardwaj et al. [[17\]](#page-7-12) outline, focusing just beneath the surface restricts lateral expansion and forcing expansion parallel to the incident beam, resulting in swelling. Another technique that results in increased hardness involves highrepetition laser pulses to redistribute ions into unique structures with enhanced properties. Ion migration is of interest because optical mechanical properties are related to elemental distribution. High-repetition rate femtosecond laser irradiation provides an opportunity to not only manipulate ionic positions, but also be spatially selective. Repetition rate is a crucial variable to ion migration as it proportionally efects localized heat accumulation. High-repetition rates accumulate signifcant heat, enabling bond-breaking and ion migration. Thermal difusion within the focal point causes a temperature gradient, therefore elements with high diffusion coefficients escape to regions of lower temperature [\[1](#page-7-0), [18,](#page-7-13) [19](#page-7-14)]. Vacancies within the laser-treated region are then occupied by network formers because the binding energy of former to oxygen is greater than former to modifer. This results in a more structured network with superior hardness. Finally, high-repetition laser pulses of low-intensity can create an environment in which structural rearrangement occurs without a redistribution of elements. Heat accumulation within the laser-focused region enables local changes to bond lengths and angles. However, before a thermal equilibration is reached, the structure is quenched. Observed structure relaxation is a result of transient laser-induced plasma generation and subsequent shock wave [\[20](#page-7-15)]. Highly focused beams are able to structurally alter a region under 1 μ m [\[21](#page-7-16)]. Glass composition and modifer content play a large role in the laser-modifed network; low modifer content shows change in Si–O network, high-modifer content observes primary variation to non-bridging oxygen (NBO) sites [\[20](#page-7-15)]. Unique laser energy regimes result in various modifcations to the glass structure: densifcation, decompaction, and ablation. We present our results and interpretations on selected commercial glasses in this paper [[22](#page-7-17), [23](#page-7-18)].

2 Materials and methods

2.1 Femtosecond laser treatment and terahertz time domain spectroscopy analysis

We used a commercial femtosecond laser system, FEM-TOLASER Scientifc XL 500 (FEMTOLASERS Produktions GmbH, Austria) for our laser treatment. The solidstate Ti:Sapphire-based high energy oscillator system provides a pulse energy of 490 nJ, pulse duration of less than 50 fs, and a repetition rate of 5.1 MHz. The XL 500 system has four major components: pump source that continuously emits green light of 532 nm, a Ti:Sapphire oscillator chamber, a laser cavity including a multi-pass Herriot cell and a prism compressor to compress the pulses into femtosecond timescale. A plano-convex lens was used to focus the collimated beam, producing a Gaussian profle of $1/e^2$ beam radius 7.5 μ m measured at the sample surface. Calculated peak exposure fluences of 1.59 J/cm² were derived from pulse energy measurements outlined by Liu [[24\]](#page-7-19). Irradiation experiments were performed on polished surfaces held at a normal incidence to the laser beam and directed to the sample fxed to a XYZ translation stage (Thorlabs, USA). The mechanical translation stage was positioned for the focal point along the surface; this was done by maximizing fuorescence of the incident beam using a visualization system (CCD camera). The stage was moved in a two-dimensional plane normal to the beam. The sample was then rastered so parallel laser lines, 15 μ m distant apart, were written across an area of 10 mm^2 at a speed of 2.2 mm/s. Figure [1](#page-2-0) shows a schematic of our setup and rastering of a sample.

Soda-lime silicate (SLS), Borofoat (BF), and aluminoborosilicate (ABS) refractive indices were characterized using terahertz time domain spectroscopy (THz-TDS, TPS Spectra 3000, Teraview, UK). Terahertz radiation is produced by a mode-locked Ti:Sapphire laser with central wavelength of 800 nm, 80 MHz repetition rate and pulse width of 100 fs. The pulse is separated into a pump and probe beam; pump beam generates THz radiation and probe beam detects THz pulses using GaAs semiconductors. Samples were mounted on a holder with an optical aperture of 4.55 mm. Reference measurements were made with the empty sample holder in air. Broadband THz pulses are converted to a frequency regime through Fourier transformation. Measurements were performed by averaging 3000 scans with a resolution of 1.200 cm−1 and scan frequency of 30 Hz.

Fig. 1 Femtosecond laser irradiation setup and beam rastering module

2.2 X‑ray photoelectron spectroscopy

All samples were cleaned with chemical detergent at room temperature, while immersed in an ultrasonic bath for 15 min. Nitrogen gas was used to dry samples before being stored in a vacuum desiccator. Prior to entering the introduction chamber, samples were placed into the ultraviolet ozone cleaner (UVOC) for 15 min to remove carbon and other atmospheric elements deposited on the surface. Survey scans were collected for qualitative analysis of elemental composition. High-resolution scans of each identifed element were collected using the same pass energy and dwell time. Elemental identifcation and concentration were determined using both CasaXPS and MultiPak 8.0 software. Relative sensitivity factors were then used to normalize area under the curve and calculate quantitative elemental compositions for each glass. All elemental concentrations come with a plus or minus 1 at% error.

2.3 Surface hardness analysis

A series of indentations were made on laser-irradiated and non-irradiated regions of aluminosilicate, Borofoat and soda-lime glass. Micro-indentations were made with a pointed indenter on a Buehler Micromet II micro-hardness indenter. Surface hardness was calculated using Vickers hardness:

$$
H_{\rm V} = 1.854 \frac{F}{d^2},\tag{1}
$$

where F is the incident force measure in grams and d is the indentation diameter or cross section. Indentations were collected using 200 and 300 g of force and a 15 s loading time, under ambient conditions. After indentation, each of the diagonal lengths in the square-shaped indentation was measured on an American Optical Microscope at 100×.

2.4 X‑ray refectometry

X-ray refectance (XRR) is a unique analysis technique well suited for determining the near-surface density (2–100 nm). Measurement was collected on a Bruker D8 Advanced X-ray Refectometer using wavelength of 154 nm from 0.000° to 3.500° 2*θ* with a step size of 0.005°. DIFFRACT.XRR software was used to analyze XRR measurements through ftting a model against the measured data. Nevot-Croce roughness correction factor was used to defne the vertical interface roughness and ft using a simulated annealing function.

3 Results and discussion

3.1 XPS analysis of glass surface chemistry

All X-ray photoelectron spectroscopy (XPS) survey scans revealed expected elemental composition on the surface. Peak identifcation was consistent with the bulk chemical analysis. High-resolution scans were collected for quantifcation of elemental composition. Elemental composition of manufacturer supplied glasses both before and after laser irradiation is found in Table [1.](#page-3-0) All composition showed a minimal change in Na ion concentration. Increased sodium concentration in SLS may be a result of the data collection and analysis; boundary position and band integration to determine composition. Minimal decrease in surface sodium content is likely a result of volatilization [\[25,](#page-7-20) [26\]](#page-7-21). In this case, observed sodium concentration falls within detectable error. Figure [2](#page-3-1) compares elemental concentration before and after laser treatment; a—Na2s at 63 eV and Al2p at 73.6 eV, b—C1s at 284.2 eV and K2p (K2p_{1/2} at 292.6 eV and K2p_{3/2} at 295.6 eV), c—Ca2p (Ca2p_{1/2} at 350.6 eV and Ca2p_{3/2} at 347.0 eV), d—O1s at 531.6 eV, e—Si2p at 102.4 eV, and f—Sn3d_{5/2} at 486.4 eV.

Table 1 Quantifed silicate glass surface chemistry before and after laser irradiation

| Glass/treatment | B | O | Na | Mg | Al | Si | K | Ca | Sn |
|---------------------|-----|------|-----|-----|-----|------|-----|-----|-----|
| ABS/untreated | 2.8 | 65.5 | 1.5 | 1.3 | 1.0 | 25.8 | 1.3 | 0.2 | 0.6 |
| ABS/treated | 2.4 | 67.1 | 1.1 | 0.3 | 0.8 | 26.2 | 1.1 | 0.4 | 0.6 |
| SLS/untreated | 0.0 | 66.4 | 2.5 | 1.6 | 0.7 | 24.6 | 1.1 | 1.8 | 1.3 |
| SLS/treated | 0.0 | 66.3 | 3.0 | 0.9 | 0.5 | 25.3 | 1.2 | 1.6 | 1.2 |
| BF/untreated | 3.0 | 66.1 | 0.7 | 0.0 | 0.8 | 28.9 | 0.4 | 0.0 | 0.1 |
| BF /treated | 2.7 | 67.5 | 0.6 | 0.0 | 0.7 | 28.0 | 0.3 | 0.0 | 0.1 |

Fig. 2 High-resolution XPS scans of SLS glass before (black) and after (red) laser irradiation

In laser-irradiated ABS glass, we observed a depletion of≤0.4% and a surface enrichment in oxygen and silicon of $\leq 1.1\%$ and 0.4%, respectively. The minimal depletion of boron, sodium, and aluminum is within the measurable associated error and standard deviation of 0.5 at%. However, thermal effects have been documented to induce the depletion of the previous elements in the literature [[27](#page-7-22)].

Similar depletions were observed in both SLS and Borofoat glasses. Surface analysis showed minimal depletion of $Mg \leq 0.8\%$ in SLS. Loss of magnesium in both SLS and ABS glasses can be a thermal effect; however, the depletion or enrichment of a cation species less than 1.5% is hard to defnitively attribute to the femtosecond laser. The enrichment of sodium along the SLS glass surface lies within the measurable standard deviation and shows no conclusive evidence of ion migration in any other cation species.

Laser-induced efects in BF glass were expected to be signifcantly diferent because of the low modifer content and lack of alkaline earth ions. BF ionic content within laser-irradiated region, seen in Fig. [3,](#page-4-0) shows no signifcant change after high-intensity pulse exposure. Elements shown in Fig. [3](#page-4-0) are as follows: a—Na1s and Al2p, b—B1s at 192.2 eV, c—C1s, d—O1s, e—Si2p, and f—Sn3d_{5/2}. Small amounts of potassium are found in Fig. [3c](#page-4-0) at 293 eV. Post-exposure high-resolution scans are nearly identical to the pristine sample, aside from the minimal shift of Si2p observed in both SLS and BF glass.

ABS high-resolution scans are shown in Fig. [4](#page-4-1). Similar to SLS and BF, laser exposure has no observable efect on ion concentration at the glass surface. XPS scans of the detectable elements in ABS glass include a—Al2p, b—B1s, c—C1s, $K2p_{1/2}$, and $K2p_{3/2}$, d—Ca2p, e—O1s, and f—Si2p. The symmetric O1 s peak indicates that the bridging oxygen (BO) to non-bridging oxygen (NBO) ratio is unafected by laser irradiation; therefore, proving femtosecond laser pulses do not cause restructuring in the glass network.

Fig. 3 High-resolution XPS scans of BF glass before (dash) and after (dot) laser irradiation

Fig. 4 High-resolution XPS scans of ABS glass before (dash) and after (dot) laser irradiation

Ion concentration along the glass surface is of interest because of the thermal and optical afects induced by the femtosecond laser (i.e., ion migration of network modifying agents that may induce surface stress layers). It has been shown that high-intensity laser pulses cause minimal change to glass surface chemistry. Unlike Luo et al. [\[18\]](#page-7-13) and Shimizu et al. [[19\]](#page-7-14), where elemental distribution was observed under high-repetition-rate femtosecond laser exposure with peak fluences of 10.7 and 63.8 J/cm^2 , respectively, experimental peak fuences in this study only reached 1.59 J/ cm². All other components showed no variation between the manufactured surface and laser-irradiated manufactured surface, therefore proving that high-intensity femtosecond laser pulses do not afect the silicate glass surface chemistry.

3.2 Surface hardness and densifcation

Both laser-irradiated and untreated glass surface indentation results are shown in Fig. [5.](#page-5-0) Untreated glass surface compositions have a standard deviation of ≤ 0.08 GPa. Post-treated surfaces observe a greater standard deviation; Borofoat and SLS approximately 0.11 GPa and ABS 0.18 GPa. Increased deviation in calculated surface hardness of laser exposed glasses is believed to result from a more highly disordered structure. High-intensity pulse irradiation will cause distortion to interatomic bond angles and lengths, therefore increasing surface hardness variability.

Vicker's hardness comparison before and after laser exposure is illustrated in Fig. [5](#page-5-0). Under ambient conditions two of three silicate systems experienced an increase in surface hardness between 18.8 and 20.2%. SLS glass surface hardness was reduced by 16.6%. Polarized light microscopy confrmed that the hardening efect in BF and ABS glasses was not a result of generating stress felds. Sample stress was observed using a polarimeter $(70 \times 90 \text{ mm}$ field, 0–140 nm retardation with orientation, and ~ 0.3 nm resolution). to ensure both surface and bulk stress remained constant throughout laser processing. Annealing low stress glasses increases the surface hardness 6–9%, at most [[28](#page-7-23)]. Given the standard efect from annealing on surface hardness, it is likely not the mechanism responsible for such a signifcant increase. Reduction of SLS surface hardness is believed to stem from its high network modifer content; nearly twice ABS. Increased modifer content reduces tetrahedra and increases Q^x species, causing silica rings to depolymerize. Open structures may be more susceptible to undergo an increase to interatomic bonding lengths and angles.

The THz refractive index spectrum for SLS and ABS glass is shown in Fig. [5](#page-5-0). The cutoff frequency occurs when the intensity falls below the noise foor, at which point the signal to noise ratio was too low to calculate accurate dielectric properties. In the case of SLS glass, pulsed laser irradiation was found to decrease the refractive index. At higher frequencies, the delta between laser-modifed and pristine decreased by approximately 50%. Identical laser exposure conditions for ABS glass resulted in a refractive index increase of 0.012 compared to an unmodifed region. The change in refractive index is consistent at higher frequencies, where $\Delta n = 0.011$. These findings are consistent with type I modifcations in both SLS and ABS due to the fact that no localized stress felds were generated and because low pulse energies can produce either a positive or negative index change depending on the type of glass [\[11](#page-7-7), [29](#page-7-24), [30](#page-7-25)].

X-ray refectometry (XRR) is a surface-sensitive X-ray scattering technique that determines material density, interface roughness, and layer thickness. Because of its

Fig. 5 Micro-indentation analysis of silicate glass surface hardness (left), refractive index as a function of frequency for soda-lime silicate and alumino-borosilicate

sensitivity to electron density, structural modification after laser exposure will be seen through X-ray scattering (although highly sensitive to roughness as it causes difuse scattering, the interface roughness remained well below the standard 2–3 nm). Figure [6](#page-6-0) shows the refectivity pattern 2*θ* versus intensity of refected X-ray photons. Pristine samples of both SLS and ABS glasses underwent density changes after laser exposure. The borosilicate observed increased scattering at higher 2*θ* and SLS scattering decreased at intermediate positions. Decreased scattering results in electron density reduction and vice versa. There is a high correlation between electron density and mass density in glass; increased electron density also increases refractive index. Interestingly, densifcation and decompaction do not occur at the same position. Decreased electron density in SLS begins around 0.75° 2*θ*, whereas the increase in ABS electron density begins at 1.5° 2*θ*. Interface roughness and densities are found in Table [2.](#page-6-1) These results validate our claim that femtosecond pulse irradiation induce structural changes in various silicate glasses.

Increasing angular ranging from 0.12° to 0.42° 2*θ* is a result of fnite dimensions for a measured sample; this part of the pattern below the critical angle is not modeled. Below 0.12° the simultaneous efect of direct beam exposure and air scattering causes increasing intensity and has been ignored. Using a curve ftting procedure on the refected profle, surface roughness and density are determined. Measured patterns were ftted by minimizing χ^2 through algorithmic refinement above the critical angle. ABS glass surface has undergone a densifcation of 5.2% after laser exposure while SLS surface density was reduced by 5.7%. The mechanism associated with the density changes is believed to be structural modifcation to interatomic bonds. As previously mentioned, reducing the

Table 2 Silicate glass surfaces analyzed using X-ray refectometry

| Composition | Surface | Roughness (nm) | Profile | Density (g) cm^3) |
|-------------|------------------|-------------------|--------------------|----------------------------------|
| ABS | Untreated 1.1946 | | No gradient | 2.20 |
| ABS | Treated | 0.8288 | No gradient 2.32 | |
| SLS. | Untreated | 1.314 | No gradient | 2.65 |
| SLS | Treated | 1.505 | No gradient 2.50 | |

bonding distance and angle on Si–O sites results in densifcation. Increasing these structural components causes decompaction and decrease in density [[31\]](#page-7-26).

4 Conclusion

In conclusion, we report surface hardening in various commercial silicate glasses. Femtosecond laser pulses have been shown to increase surface hardness in glasses with low modifier content 18.8–20.2% and decrease surface hardness of high-modifer content glasses by 16.6%. XPS and polarized microscopy validate the hardening mechanism operates without afecting surface chemistry or inducing residual stress layers within detectable limit of these tools. Scattering deviations in XRR characterization verify electron density deviations, therefore, supporting a change in near-surface density. Using a high-intensity femtosecond pulse laser, the surface hardness of glasses with variable modifer has shown contrasting efects. These results show promise for rapid strengthening of commercial glasses.

Fig. 6 X-ray refectometry measurements before (black) and after (red) laser modifcation; left ABS, right SLS

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